

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10522798	TABUCHI ET AL.
	Examiner	Art Unit
	Jaisle, Cecilia M	1624

SEARCHED

Class	Subclass	Date	Examiner
544	236	4/23/2007	Cecilia Jaisle

SEARCH NOTES

Search Notes	Date	Examiner
STN (CAS structure) and Inventor Names searched by STIC	4/23/2007	Cecilia Jaisle

INTERFERENCE SEARCH

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544	236	6/15/2007	Cecilia Jaisle

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Inventor Names searched in PALM	6/15/2007	Cecilia Jaisle

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544	236	6/15/2007	Cecilia Jaisle